# Notice of References Cited Application/Control No. 10/814,854 Examiner Alvin J. Stewart Applicant(s)/Patent Under Reexamination REALYVASQUEZ ET AL. Art Unit 3774 Page 1 of 3

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,413,599 A	05-1995	Imachi et al.	623/1.24
*	В	US-2004/0138745 A1	07-2004	Macoviak et al.	623/002.36
*	С	US-7,175,656 B2	02-2007	Khairkhahan, Alexander	623/1.26
*	D	US-2005/0075725 A1	04-2005	Rowe, Stanton J.	623/002.14
*	Е	US-6,168,614 B1	01-2001	Andersen et al.	623/1.26
*	F	US-6,425,916 B1	07-2002	Garrison et al.	623/2.11
*	G	US-7,125,418 B2	10-2006	Duran et al.	623/1.24
*	Ι	US-4,222,126	09-1980	Boretos et al.	623/2.19
*	-	US-6,283,994 B1	09-2001	Moe et al.	623/2.12
*	J	US-3,548,417	12-1970	KISCHER JANE N; et. al.	623/2.17
*	K	US-3,445,916	05-1969	SCHULTE RUDOLF R	29/458
*	L	US-7,182,093	02-2007	Call et al.	137/15.18
*	М	US-7,011,094 B2	03-2006	Rapacki et al.	128/207.15

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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### **NON-PATENT DOCUMENTS**

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# Notice of References Cited Application/Control No. 10/814,854 Examiner Alvin J. Stewart Applicant(s)/Patent Under Reexamination REALYVASQUEZ ET AL. Art Unit Page 2 of 3

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,821,297 B2	11-2004	Snyders, Robert V.	623/2.18
*	В	US-6,666,885 B2	12-2003	Moe, Riyad	623/2.12
*	O	US-6,719,787 B2	04-2004	Cox, James L.	623/2.12
*	D	US-2005/0228495 A1	10-2005	Macoviak, John A.	623/002.18
*	Е	US-2004/0225354 A1	11-2004	Allen et al.	623/002.11
*	F	US-2001/0021872	09-2001	Bailey et al.	623/1.24
*	G	US-6,503,272 B2	01-2003	Duerig et al.	623/1.24
*	Н	US-6,482,228 B1	11-2002	Norred, Troy R.	623/2.17
*	I	US-6,299,637 B1	10-2001	Shaolian et al.	623/1.24
*	J	US-4,994,077	02-1991	Dobben, Richard L.	623/2.2
*	K	US-7,217,284 B2	05-2007	Houser et al.	623/1.26
*	L	US-2006/0229708 A1	10-2006	Powell et al.	623/001.24
*	М	US-2002/0138135 A1	09-2002	Duerig et al.	623/1.24

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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### **NON-PATENT DOCUMENTS**

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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/814,854 Examiner Alvin J. Stewart Applicant(s)/Patent Under Reexamination REALYVASQUEZ ET AL. Art Unit 3774 Page 3 of 3

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,358,518 A	10-1994	Camilli, Sante	623/1.24
*	В	US-2005/0267572 A1	12-2005	Schoon et al.	623/002.11
*	O	US-2004/0193259 A1	09-2004	Gabbay, Shlomo	623/002.11
*	D	US-2003/0083742 A1	05-2003	Spence et al.	623/2.16
*	ш	US-7,070,618 B2	07-2006	Streeter, Richard B.	623/2.36
*	F	US-6,524,338 B1	02-2003	Gundry, Steven R.	623/2.11
*	O	US-6,419,695 B1	07-2002	Gabbay, Shlomo	623/2.36
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.